



SCOPE OF ACCREDITATION TO ISO/IEC 17025:2005  
& ANSI/NCSL Z540-1-1994

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CALIBRATION

Valid To: December 31, 2019

Certificate Number: 1318.01

In recognition of the successful completion of the A2LA evaluation process, accreditation is granted to this laboratory to perform the following calibrations<sup>1,12</sup>:

I. Acoustics & Vibration

Parameter/Range	Frequency	CMC <sup>2, 13</sup> (±)	Comments
Sound Level – Measuring Equipment <sup>3</sup>			
94 dB	250 Hz 1 kHz	0.4 dB 0.4 dB	Sound level generator
114 dB	250 Hz 1 kHz	0.4 dB 0.4 dB	
Sound Level – Measure <sup>3</sup>			
(35 to 130) dB	(63 to 8000) Hz	1.8 dB	Sound level meter

II. Chemical

Parameter/Equipment	Range	CMC <sup>2, 13</sup> (±)	Comments
pH <sup>3</sup> –			
Individual Values	(4, 7, 10) pH units	0.03 pH units	Direct method
Transfer	(4 to 10) pH units	0.03 pH units	Transfer method
Electrical Substitution	(0 to 15) pH units	0.001 pH units	Simulation
Conductivity <sup>3</sup> –			
Solution (Fixed Points)	10 µS 100 µS 1000 µS 10 000 µS	0.65 µS 0.90 µS 3.9 µS 29 µS	Direct method
Transfer	(1 to 10) µS (10 to 100) µS (101 to 1000) µS (1001 to 10 000) µS (10 001 to 100 000) µS	0.66 µS 0.95 µS 5.8 µS 44 µS 300 µS	Transfer method
Resistance Substitution	(10 to 100) µS (101 to 1000) µS (1001 to 10 000) µS (10 001 to 100 000) µS (100 001 to 1 000 000) µS	0.08 µS 0.09 µS 0.08 µS 0.06 µS 0.04 µS	Simulation

III. Dimensional

Parameter/Equipment	Range	CMC <sup>2,4</sup> (±)	Comments
Length Measurement <sup>3</sup> – Gage Blocks, Length Standards			
Standard Size Gages	(0.005 to 0.035) in (0.04 to 0.5) in (0.55 to 1.0) in 2 in 3 in 4 in 5 in 6 in 7 in 8 in 10 in 12 in 16 in 20 in	2.5 µin 2.3 µin 2.7 µin 3.7 µin 4.8 µin 5.9 µin 7.6 µin 8.9 µin 10 µin 11 µin 13 µin 14 µin 18 µin 21 µin	Mechanical comparison
Non-Standard Size Gages	(0.001 to 0.005) in (0.005 to 1.0) in (1.1 to 6.0) in (>6.1 to 20.0) in (>20.1 to 40.0) in	4.8 µin (3.0 + 0.78L) µin (5.1 + 0.74L) µin (11 + 0.45L) µin (20 + 0.38L) µin	
Feeler Gages & Shims	Up to 1.0 in Up to 25.4 mm	15 µin 0.38 µm	Gage blocks; universal measuring machines
Height Masters	Up to 24 in Up to 600 mm	24 µin 0.61 µm	Surface plate, gage blocks, indicator & gage amplifier
Height Gages	Up to 60 in Up to 1500 mm	(3 + 3.5L + 0.6R) µin (0.08 + 0.0035L + 0.6R) µm	Gage blocks, surface plate

Parameter/Equipment	Range	CMC <sup>2,4</sup> (±)	Comments
Length Measuring Equipment <sup>3</sup> – Universal Measuring Machines & Bench Micrometers  Standard Length  Non-Standard Length	(>0.005 to 1.0) in 2 in 3 in 4 in 5 in 6 in 7 in 8 in 10 in 12 in 16 in 20 in  (20 to 40) in	(2.5 + 0.5L + 0.6R) μin (4.2 + 0.6R) μin (4.9 + 0.6R) μin (6.4 + 0.6R) μin (8.1 + 0.6R) μin (8.9 + 0.6R) μin (9.7 + 0.6R) μin (11 + 0.6R) μin (12 + 0.6R) μin (14 + 0.6R) μin (17 + 0.6R) μin (20 + 0.6R) μin  (20 + 0.86L + 0.6R) μin	Mechanical comparison
Micrometers <sup>3</sup>	Up to 20 in Up to 500 mm	(7 + 4.5L + 0.6R) μin (0.2 + 0.005L + 0.6R) μm	Gage blocks
Calipers <sup>3</sup>	Up to 80 in Up to 2000 mm	(24 + 4.6L + 0.6R) μin (0.6 + 0.005L + 0.6R) μm	Gage blocks
LVDT's & Indicators <sup>3</sup>	Up to 12 in Up to 300 mm	(3 + 3.3L + 0.6R) μin (0.08 + 0.003L + 0.6R) μm	Gage blocks, surface plate
Angle Blocks <sup>3</sup>	0.25° to 90°	(13 + 0.07θ) arcsec	Mechanical comparison  θ is the numerical value of the nominal angle measured in degrees

Parameter/Equipment	Range	CMC <sup>2, 4, 9</sup> (±)	Comments
Chamfer Gage <sup>3</sup>	(0.15 to 2) in (3.8 to 50) mm	290 μin 7.5 μm	Reference rings
Coordinate Measuring Machines (CMMs) <sup>3</sup> –			
Linear Displacement Accuracy	Up to 72 in Up to 1800 mm	(8 + 3L) μin (0.2 + 0.003L) μm	Gage blocks, optical flats
Volumetric Repeatability	-----	100 μin 2.5 μm	Ball bar
Probe Repeatability	-----	25 μin 0.6 μm	Reference sphere
Cylindrical Square <sup>3</sup> –			
Squareness	Up to 24 in Up to 600 mm	25 μin 0.6 μm	Mechanical comparison
Levels <sup>3</sup>			
Electronic Levels and Inclination Meters	Up to 1000 arcsec	0.23 arcsec	Mechanical comparison
Spirit Levels and Clinometers	Up to 48 in Up to 1200 mm	(50 + 0.6R) μin/ft (1.3 + 0.6R) μm/m	
Optical Flats and Optical Parallels <sup>3</sup>	Up to 4 in Up to 100 mm	6.4 μin 0.16 μm	Reference flat & mechanical comparison
Optical Comparators & Microscopes <sup>3</sup> –			
Measuring Stage Travel	Up to 12 in Up to 300 mm	110 μin 2.8 μm	Glass scales
Squareness	----	110 μin 2.8 μm	
Magnification	5x to 100x	0.024 x Mag %	Reticule or gage balls

Parameter/Equipment	Range	CMC <sup>2,4</sup> (±)	Comments
Diameter Measurement <sup>3</sup> –			
Pins & Plugs	(0.003 to 40) in (0.076 to 1000) mm	(8.0 + 0.8D) μin (0.2 + 0.0007D) μm	Mechanical comparison
CMM Spheres & Gage Balls	(0.015 to 4.0) in (0.38 to 100) mm	12 μin 0.3 μm	
Thread Wires	(0.003 to 0.825) in (0.076 to 30) mm	10 μin 0.25 μm	
Thread Plugs			
Pitch Diameter	(4 to 80) TPI	(75 + 2D) μin (2 + 0.002D) μm	UMM w/thread wires
Major Diameter	Up to 20 in Up to 500 mm	(8.0 + 0.8D) μin (0.2 + 0.0007D) μm	Universal measuring machine
Rings & Bores	(0.02 to 33) in (0.5 to 838) mm	(5 + 0.9D) μin (0.1 + 0.0009D) μm	Universal measuring machine
Thread Rings			
Pitch Diameter	Up to 20 in Up to 500 mm	(66 + 0.26D) μin (1.7 + 0.0066D) μm	Universal measuring machine w/thread balls
Minor Diameter	Up to 20 in Up to 500 mm	45 μin 1.0 μm	UMM

Parameter/Equipment	Range	CMC <sup>2,4,9</sup> (±)	Comments
Diameter – Measuring Equipment <sup>3</sup>			
Comparators and Similar Equipment			
Standard Length	(>0.005 to 1.0) in 2 in 3 in 4 in 5 in 6 in 7 in 8 in 10 in 12 in 16 in 20 in	3.0 µin 4.0 µin 5.0 µin 6.5 µin 8.0 µin 9.0 µin 10 µin 11 µin 12 µin 14 µin 17 µin 20 µin	Mechanical comparison
Non-Standard Length	(21 to 72) in Up to 1800 mm	$(20 + 1.0L + 0.6R)$ µin $(0.5 + 0.025L + 0.6R)$ µm	Mechanical comparison
Tri-Point Bore Equipment	Up to 10 in Up to 250 mm	$(5 + 1.8L + 0.6R)$ µin $(0.1 + 0.5L + 0.6R)$ µm	Reference rings
Parallels <sup>3</sup>	Up to 12 in Up to 300 mm	40 µin 1.0 µm	Parallels <sup>3</sup>
Straight Edges <sup>3</sup>	Up to 60 in Up to 1500 mm	40 µin/ft 1.0 µm/m	Mechanical comparison
Planeators <sup>3</sup>	Up to 48 in Up to 1200 mm	57 µin 1.5 µm	Laser system
Profilometers & Surface Testers <sup>3</sup> –	Ra 120 µin Ra 3 µm	8.4 µin 0.2 µm	Roughness standards
Indirect Verification of Ra Measurement	Ra (10 to 200) µin Ra (0.25 to 5) µm	2.6 µin + 7.0 % 0.07 µm + 7.0 %	
Protractors <sup>3</sup> –			
Bevel and Digital	(0 to 180)°	220 arcsec	Mechanical comparison

Parameter/Equipment	Range	CMC <sup>2,4,9</sup> (±)	Comments
Radius Gage <sup>3</sup>	Up to 2 in	430 μin	Optical comparison
Roughness Standards & Patches <sup>3</sup> –  ISO Type C	Ra (10 to 200) μin Ra (0.25 to 5) μm	1.5 μin + 7.0 % 0.04 μm + 7.0 %	Reference standard & mechanical comparison
Sine Plates & Bars <sup>3</sup> –  Parallelism  Angle	Up to 15 in Up to 380 mm  Up to 2 in Up to 50 mm	78 μin 1.2 μm  (10 + 0.6Θ) arcsec (10 + 0.6Θ) arcsec	Mechanical comparison, Θ is the numerical value of the nominal angle measured in degrees
Thread Pitch Gages <sup>3</sup>	(Up to 6) in	430 μin	Optical comparison
Torque Wheels/Arms <sup>3</sup>	Up to 40 in Up to 1000 mm	(470 + 2L) μin (12 + 0.002L) μm	Mechanical comparison
V Blocks <sup>3</sup> –  V-Groove Squareness	Up to 4 in Up to (24 × 24 × 24) in Up to (600 × 600 × 600) mm	64 μin 45 μin  1 μm	Mechanical comparison
Adjustable Thread Rings	Up to 2 in Up to 50 mm	(140 + 27D) μin (3.5 + 0.027D) μm	Class (X) master setting plugs



IV. Dimensional Testing/Calibration<sup>1</sup>

Parameter/Equipment	Range	CMC <sup>2, 4, 9, 13</sup> ( $\pm$ )	Comments
Length <sup>8</sup> –			
2D	Up to 30 in Up to 760 mm	200 $\mu$ in 5.1 $\mu$ m	CMM
1D	Up to 6 in Up to 12 in Up to 1 in Up to 6 in Up to 1 in	(420 + 0.52L) $\mu$ in 1500 $\mu$ in 150 $\mu$ in 150 $\mu$ in 600 $\mu$ in	Optical comparison Caliper Micrometer Depth micrometer Gage pins
Squareness <sup>3, 8</sup>	Up to 0.060 in Up to 1.5 mm	20 $\mu$ in 0.5 $\mu$ m	Mechanical comparison
Volume <sup>8</sup> –			
X-Axis	Up to 18 in Up to 450 mm	(300 + 43L) $\mu$ in (7.5 + 0.043L) $\mu$ m	CMM - volume calculated based on independent linear measurements
Y-Axis	Up to 20 in Up to 500 mm	(300 + 44L) $\mu$ in (7.5 + 0.045L) $\mu$ m	
Z-Axis	Up to 16 in Up to 400 mm	(300 + 42L) $\mu$ in (7.5 + 0.041L) $\mu$ m	
Surface Finish <sup>8</sup>	Ra (10 to 200) $\mu$ in	1.5 $\mu$ in + 7.0 %	Reference standard & mechanical comparison

V. Electrical – DC/Low Frequency

Parameter/Range	Frequency	CMC <sup>2,7,9</sup> (±)	Comments
AC Current – Generate <sup>3</sup>			
(0 to 220) µA	(10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.079 % + 34 nA 0.04 % + 25 nA 0.016 % + 22 nA 0.07 % + 47 nA 0.19 % + 93 nA	Fluke 5700A
(0 to 2.2) mA	(10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.081 % + 47 µA 0.041 % + 41 µA 0.017 % + 41 µA 0.067 % + 0.54 µA 0.19 % + 0.94 µA	
(0 to 22) mA	(10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.081 % + 0.47 mA 0.041 % + 0.41 mA 0.017 % + 0.41 mA 0.07 % + 4.7 mA 0.19 % + 9.4 µA	
(0 to 220) mA	(10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.068 % + 39 µA 0.036 % + 17 µA 0.013 % + 13 µA 0.07 % + 47 µA 0.19 % + 94 µA	
(0 to 2.2) A	40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	1.8 % + 4.1 mA 2.2 % + 47 mA 5.2 % + 93 mA	Fluke 5700A w/ Fluke 5500A/coil
Clamp on Only			Fluke 5520A w/ Fluke 5500A/coil
(2.2 to 110) A	(45 to 440) Hz	8.4 % of output	
(110 to 1025) A	(45 to 440) Hz	14 % mA/A of output	

Parameter/Range	Frequency	CMC <sup>2,7</sup> ( $\pm$ )	Comments
AC Current – Measure <sup>3</sup>			
(0 to 200) $\mu$ A	(1 to 10) Hz 10 Hz to 10 kHz (10 to 30) kHz (30 to 100) kHz	0.041 % + 20 nA 0.042 % + 20 nA 0.082 % + 20 nA 0.48 % + 20 nA	Fluke 8508A
(0 to 2) mA	(1 to 10) Hz 10 Hz to 10 kHz (10 to 30) kHz (30 to 100) kHz	0.031 % + 0.2 $\mu$ A 0.031 % + 0.2 $\mu$ A 0.071 % + 0.2 $\mu$ A 0.47 % + 0.2 $\mu$ A	
(0 to 20) mA	(1 to 10) Hz 10 Hz to 10 kHz (10 to 30) kHz (30 to 100) kHz	0.04 % + 2 $\mu$ A 0.04 % + 2 $\mu$ A 0.08 % + 2 $\mu$ A 0.48 % + 2 $\mu$ A	
(0 to 200) mA	(1 to 10) Hz 10 Hz to 10 kHz (10 to 30) kHz	0.041 % + 20 $\mu$ A 0.041 % + 20 $\mu$ A 0.081 % + 20 $\mu$ A	
(0 to 2) A	10 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz	0.071 % + 0.2 mA 0.083 % + 0.2 mA 0.35 % + 0.2 mA	
(0 to 20) A	10 Hz to 2 kHz (2 to 10) kHz	0.11 % + 0.2 mA 0.3 % + 0.2 mA	

Parameter/Range	Range	CMC <sup>2,7</sup> (±)	Comments
AC Power – Generate <sup>3</sup> (45 to 65) Hz			
(3.3 to 8.999) mA	(33 to 330) mV (0.33 to 1020) V	0.25 % 0.21 %	Fluke 5520A
(9 to 32.999) mA	(33 to 330) mV (0.33 to 1020) V	0.18 % 0.12 %	
(33 to 89.99) mA	(33 to 330) mV (0.33 to 1020) V	0.25 % 0.21 %	
(90 to 329.99) mA	(33 to 330) mV (0.33 to 1020) V	0.18 % 0.10 %	
(0.33 to 0.8999) A	(33 to 330) mV (0.33 to 1020) V	0.19 % 0.18 %	
(0.9 to 2.1999) A	(33 to 330) mV (0.33 to 1020) V	0.20 % 0.17 %	
(2.2 to 4.4999) A	(33 to 330) mV (0.33 to 1020) V	0.20 % 0.19 %	
(4.5 to 20.5) A	(33 to 330) mV (0.33 to 1020) V	0.21 % 0.13 %	

Parameter/Range	Frequency	CMC <sup>2, 7, 13</sup> ( $\pm$ )	Comments
AC Voltage – Generate <sup>3</sup>			
(0 to 2.2) mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz	0.065 % + 6.4 $\mu$ V 0.028 % + 5.8 $\mu$ V 0.014 % + 5.9 $\mu$ V 0.048 % + 13 $\mu$ V 0.11 % + 21 $\mu$ V 0.15 % + 39 $\mu$ V 0.21 % + 77 $\mu$ V 0.56 % + 77 $\mu$ V	Fluke 5700A
(0 to 22) mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz	0.069 % + 7.3 $\mu$ V 0.028 % + 7.1 $\mu$ V 0.014 % + 7.1 $\mu$ V 0.047 % + 7.1 $\mu$ V 0.11 % + 9.8 $\mu$ V 0.15 % + 18 $\mu$ V 0.21 % + 35 $\mu$ V 0.55 % + 37 $\mu$ V	
(0 to 220) mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz	0.069 % + 19 $\mu$ V 0.028 % + 13 $\mu$ V 0.013 % + 13 $\mu$ V 0.047 % + 13 $\mu$ V 0.11 % + 36 $\mu$ V 0.13 % + 36 $\mu$ V 0.21 % + 51 $\mu$ V 0.41 % + 0.13 mV	
(0 to 2.2) V	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz	0.068 % + 0.05 mV 0.021 % + 14 $\mu$ V 0.008 % + 12 $\mu$ V 0.016 % + 11 $\mu$ V 0.032 % + 23 $\mu$ V 0.055 % + 28 $\mu$ V 0.14 % + 62 $\mu$ V 0.28 % + 1.2 mV	
(0 to 22) V	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz	0.07 % + 1.2 mV 0.021 % + 0.1 mV 0.01 % + 84 $\mu$ V 0.016 % + 75 $\mu$ V 0.032 % + 63 $\mu$ V 0.07 % + 2 mV 0.17 % + 5.8 mV 0.35 % + 11 mV	

Parameter/Range	Frequency	CMC <sup>2,7</sup> (±)	Comments
AC Voltage – Generate <sup>3</sup> (cont)			
(0 to 220) V	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz	0.07 % + 12 mV 0.021 % + 3.6 mV 0.011 % + 1.5 mV 0.029 % + 4.7 mV 0.07 % + 12 mV 0.19 % + 130 mV	Fluke 5700A
(0 to 1100) V	50 Hz to 1 kHz	0.0091 % + 21 mV	
AC Voltage – Measure <sup>3</sup>			
(0 to 200) mV	(1 to 10) Hz (10 to 40) Hz (40 to 100) Hz (0.1 to 2) kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz	0.021 % + 14 μV 0.017 % + 4 μV 0.014 % + 4 μV 0.013 % + 2 μV 0.016 % + 4 μV 0.040 % + 8 μV 0.090 % + 20 μV	Fluke 8508A
(0.2 to 2) V	(1 to 10) Hz (10 to 40) Hz (40 to 100) Hz (0.1 to 2) kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz (100 to 300) kHz (0.3 to 1) MHz	0.019 % + 120 μV 0.014 % + 20 μV 0.011 % + 20 μV 89 μV/V + 20 μV 0.013 % + 20 μV 0.026 % + 40 μV 0.068 % + 200 μV 0.37 % + 2 mV 1.3 % + 20 mV	
(2 to 20) V	(1 to 10) Hz (10 to 40) Hz (40 to 100) Hz (0.1 to 2) kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz (100 to 300) kHz (0.3 to 1) MHz	0.019 % + 1.2 mV 0.014 % + 0.2 mV 0.011 % + 0.2 mV 90 μV/V + 0.2 mV 0.013 % + 0.2 mV 0.026 % + 0.4 mV 0.068 % + 2 mV 0.37 % + 20 mV 2.2 % + 200 mV	
(20 to 200) V	(1 to 10) Hz (10 to 40) Hz (40 to 100) Hz (0.1 to 2) kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz	0.020 % + 12 mV 0.014 % + 2 mV 0.011 % + 2 mV 90 μV/V + 2 mV 0.013 % + 2 mV 0.026 % + 4 mV 0.068 % + 20 mV	

Parameter/Range	Frequency	CMC <sup>2, 7, 9, 13</sup> ( $\pm$ )	Comments
AC Voltage – Measure <sup>3</sup> (cont)  (200 to 1000) V  High Voltage (0 to 28) kV	  (1 to 10) Hz (10 to 40) Hz (0.04 to 10) kHz (10 to 30) kHz (30 to 100) kHz  60 Hz	  0.019 % + 70 mV 0.015 % + 20 mV 0.014 % + 20 mV 0.027 % + 40 mV 0.071 % + 200 mV  1.7 V + 0.052 V/V	  Fluke 8508A  Agilent 34401A w/ Fluke 80k-40
Capacitance – Generate <sup>3</sup>  < 3.3 nF (3.3 to 11) nF (11 to 33) nF (33 to 110) nF (110 to 330) nF (0.33 to 1.1) $\mu$ F (1.1 to 3.3) $\mu$ F (3.3 to 11) $\mu$ F (11 to 33) $\mu$ F (33 to 110) $\mu$ F (110 to 330) $\mu$ F (0.33 to 1.1) mF (1.1 to 3.3) mF (3.3 to 11) mF (11 to 33) mF (33 to 110) mF	  10 Hz to 10 kHz 10 Hz to 1 kHz 10 Hz to 1 kHz 10 Hz to 1 kHz 10 Hz to 1 kHz (10 to 600) Hz (10 to 300) Hz (10 to 150) Hz (10 to 120) Hz (10 to 80) Hz (10 to 50) Hz (10 to 20) Hz (10 to 6) Hz (10 to 2) Hz (10 to 0.6) Hz (10 to 0.2) Hz	  0.93 % 0.41 % 0.64 % 0.40 % 0.40 % 0.40 % 0.40 % 0.41 % 0.58 % 0.63 % 0.63 % 0.63 % 0.63 % 0.65 % 0.63 % 0.98 % 1.4 %	  Fluke 5520A
Capacitance – Measure <sup>3</sup>  (1 to 100) nF  (1 to 1000) $\mu$ F  (1 to 1000) pF	  1 kHz  1 kHz  1 kHz	  0.00088 nF + 0.0005 nF/nF  0.0042 $\mu$ F/ $\mu$ F  0.023 pF + 0.00048 pF/pF	  Hameg LCR meter

Parameter/Equipment	Range	CMC <sup>2,7,9</sup> (±)	Comments
DC Current – Measure <sup>3</sup>	(0 to 200) µA (0 to 2) mA (0 to 20) mA (0 to 200) mA (0 to 2) A (0 to 20) A  (0 to 500) A	3.9 µA/A + 2 nA 3.9 µA/A + 20 nA 5.3 µA/A + 0.21 µA 24 µA/A + 5.4 µA 0.013 % + 0.23 mA 0.043 % + 0.82 µA  0.16 A + 0.000 19 A/A	Fluke 8508A      w/ current shunt
DC Current – Generate <sup>3</sup>	(0 to 220) µA (0 to 2.2) mA (0 to 22) mA (0 to 220) mA (0 to 2.2) A (0 to 3) A (0 to 11) A (0 to 20.5) A  (0 to 1000) A	47 µA/A + 7 nA 41 µA/A + 8.4 nA 41 µA/A + 51 nA 52 µA/A + 0.83 µA 91 µA/A + 20 µA 0.028 % + 0.4 mA 0.042 % + 2.4 mA 0.054 % + 14 mA  0.31 % + 64 mA	Fluke 5700A         w/ Fluke 5500A/coil
DC Power – Generate <sup>3</sup>  (0.33 to 329.99) mA (0.33 to 2.9999) A (3 to 20.5) A	(0.33 to 1020) V (0.33 to 1020) V (0.33 to 1020) V	0.05 % 0.04 % 0.09 %	Fluke 5520A
DC Voltage – Generate <sup>3</sup>  Fixed Point	(0 to 220) mV (0.2 to 2.2) V (2.2 to 11) V (11 to 22) V (22 to 220) V (220 to 1000) V  10 V	8.6 µV/V + 0.88 µV 8 µV/V + 1.5 µV 7.7 µV/V + 8.6 µV 8.1 µV/V + 9 µV 9.2 µV/V + 0.12 mV 11 µV/V + 0.88 mV  0.31 µV/V	Fluke 5700A      Fluke 732B
DC Voltage – Measure <sup>3</sup>  High Voltage	(0 to 200) mV (0 to 2) V (0 to 20) V (0 to 200) V (0 to 1050) V  (1 to 20) kV (20 to 35) kV (35 to 40) kV	5.2 µV/V + 0.3 µV 3.9 µV/V + 0.83 µV 2.3 µV/V + 58 µV 6.4 µV/V + 53 µV 6.4 µV/V + 0.62 mV  2.0 % 1.0 % 2.0 %	Fluke 8508A      DMM w/ Fluke 80k-40



Parameter/Equipment	Range	CMC <sup>2</sup> (±)	Comments
Electrical Calibration of RTD Indicators – Generate <sup>3</sup>			
Pt 385, 100 Ω	(-200 to -80) °C	0.06 °C	Fluke 5520A
	(-80 to 0) °C	0.06 °C	
	(0 to 100) °C	0.08 °C	
	(100 to 300) °C	0.11 °C	
	(300 to 400) °C	0.12 °C	
	(400 to 630) °C	0.14 °C	
	(630 to 800) °C	0.27 °C	
Pt 385, 200 Ω	(-200 to -80) °C	0.05 °C	
	(-80 to 0) °C	0.05 °C	
	(0 to 100) °C	0.05 °C	
	(100 to 200) °C	0.06 °C	
	(200 to 300) °C	0.14 °C	
	(300 to 400) °C	0.15 °C	
	(400 to 600) °C	0.17 °C	
(600 to 630) °C	0.19 °C		
Pt 385, 500 Ω	(-200 to -80) °C	0.05 °C	
	(-80 to 0) °C	0.06 °C	
	(0 to 100) °C	0.06 °C	
	(100 to 200) °C	0.07 °C	
	(200 to 300) °C	0.10 °C	
	(300 to 400) °C	0.10 °C	
	(400 to 600) °C	0.11 °C	
(600 to 630) °C	0.13 °C		
Pt 385, 1000 Ω	(-200 to -80) °C	0.04 °C	
	(-80 to 0) °C	0.04 °C	
	(0 to 100) °C	0.05 °C	
	(100 to 200) °C	0.06 °C	
	(200 to 300) °C	0.07 °C	
	(300 to 400) °C	0.09 °C	
	(400 to 600) °C	0.09 °C	
(600 to 630) °C	0.27 °C		
Pt 3926, 100 Ω	(-200 to -80) °C	0.06 °C	
	(-80 to 0) °C	0.05 °C	
	(0 to 100) °C	0.07 °C	
	(100 to 300) °C	0.09 °C	
	(300 to 400) °C	0.10 °C	
(400 to 630) °C	0.12 °C		

Parameter/Equipment	Range	CMC <sup>2</sup> (±)	Comments
Electrical Calibration of RTD Indicators – Generate <sup>3</sup> (cont)			
Pt 3916, 100 Ω	(-200 to -190) °C (-190 to -80) °C (-80 to 0) °C (0 to 100) °C (100 to 260) °C (260 to 300) °C (300 to 400) °C (400 to 600) °C (600 to 630) °C	0.25 °C 0.05 °C 0.05 °C 0.06 °C 0.07 °C 0.08 °C 0.09 °C 0.11 °C 0.23 °C	Fluke 5520A
Electrical Calibration of Thermocouple Indicators – Generate and Measure <sup>3</sup>			
Type E	(-250 to -100) °C (-100 to -25) °C (-25 to 350) °C (350 to 650) °C (650 to 1000) °C	0.58 °C 0.19 °C 0.17 °C 0.19 °C 0.25 °C	Fluke 5520A
Type J	(-210 to -100) °C (-100 to -30) °C (-30 to 150) °C (150 to 760) °C (760 to 1200) °C	0.32 °C 0.19 °C 0.17 °C 0.20 °C 0.27 °C	
Type K	(-200 to -100) °C (-100 to -25) °C (-25 to 120) °C (120 to 1000) °C (1000 to 1372) °C	0.39 °C 0.21 °C 0.19 °C 0.31 °C 0.47 °C	
Type N	(-200 to -100) °C (-100 to -25) °C (-25 to 120) °C (120 to 410) °C (410 to 1300) °C	0.50 °C 0.30 °C 0.24 °C 0.26 °C 0.34 °C	
Type R	(0 to 250) °C (250 to 400) °C (400 to 1000) °C (1000 to 1767) °C	0.69 °C 0.44 °C 0.40 °C 0.49 °C	

Parameter/Equipment	Range	CMC <sup>2,4</sup> (±)	Comments
Electrical Calibration of Thermocouple Indicators – Generate and Measure <sup>3</sup> (cont)			
Type S	(0 to 250) °C (250 to 1000) °C (1000 to 1400) °C (1400 to 1767) °C	0.57 °C 0.45 °C 0.44 °C 0.56 °C	Fluke 5520A
Type T	(-250 to -150) °C (-150 to 0) °C (0 to 120) °C (120 to 400) °C	0.73 °C 0.28 °C 0.19 °C 0.17 °C	
Type U	(-200 to 0) °C (0 to 600) °C	0.65 °C 0.32 °C	
Magnetic Flux Density – Generate <sup>3</sup> , (Gauss Meters)	(0 to 35) G	(0.26 + 0.6R)	Helmholtz coils and DMM

Parameter/Equipment	Frequency	CMC <sup>2,13</sup> (±)	Comments
Inductance – Measure <sup>3</sup>			
1 μH to 100 H	1 kHz	0.5 %	Hameg LCR meter

Parameter/Equipment	Range	CMC <sup>2,7,9</sup> (±)	Comments
Oscilloscopes <sup>3</sup> –			
Vertical Deflection			
1 kHz Square Wave into a 50 Ω Load	1 mV to 6.6 V <sub>pk-pk</sub>	0.90 % + 40 μV	Fluke 5522A/SC1100
1 kHz Square Wave into a 1 MΩ Load	1 mV to 130 V <sub>pk-pk</sub>	0.37 % + 40 μV	
Flatness			
Leveled Sine Wave			
5 mV to 5.5 V	50 kHz to 100 MHz	2.6 % + 100 μV	
ref @ 50 kHz	(100 to 300) MHz	2.8 % + 100 μV	
Bandwidth	(300 to 600) MHz	5.0 % + 100 μV	
	(600 to 1100) MHz	6.2 % + 100 μV	
Rise Time	<300 ps	+20 ps / -117 ps	
Time Interval	1 ns to 100 ms 100 ms to 5 s	3.1 μs/s (32 + 1000t) μs/s	
			t = time in seconds
Resistance – Generate <sup>3</sup>	(0 to 11) Ω (11 to 33) Ω (33 to 110) Ω (110 to 330) Ω (0.33 to 1.1) kΩ (1.1 to 3.3) kΩ (3.3 to 11) kΩ (11 to 33) kΩ (33 to 110) kΩ (110 to 330) kΩ (0.33 to 1.1) MΩ (1.1 to 3.3) MΩ (3.3 to 11) MΩ (11 to 33) MΩ (33 to 110) MΩ (110 to 330) MΩ (330 to 1100) MΩ	46 μΩ/Ω + 1.2 mΩ 23 μΩ/Ω + 2.2 mΩ 23 μΩ/Ω + 2.7 mΩ 22 μΩ/Ω + 6 mΩ 22 μΩ/Ω + 13 mΩ 22 μΩ/Ω + 60 mΩ 22 μΩ/Ω + 140 mΩ 22 μΩ/Ω + 0.6 Ω 23 μΩ/Ω + 1.4 Ω 25 μΩ/Ω + 6.5 Ω 26 μΩ/Ω + 15 Ω 46 μΩ/Ω + 120 Ω 0.011 % + 0.58 kΩ 0.02 % + 6.1 kΩ 0.041 % + 23 kΩ 0.23 % + 0.5 MΩ 1.3 % + 6.3 MΩ	Fluke 5520A



Parameter/Equipment	Range	CMC <sup>2,7,9</sup> (±)	Comments
Resistance – Generate <sup>3</sup> (cont)			
Fixed points	1 Ω 1.9 Ω 10 Ω 19 Ω 100 Ω 190 Ω 1 kΩ 1.9 kΩ 10 kΩ 19 kΩ 100 kΩ 190 kΩ 1 MΩ 1.9 MΩ 10 MΩ 19 MΩ 100 MΩ	95 μΩ/Ω 95 μΩ/Ω 28 μΩ/Ω 27 μΩ/Ω 17 μΩ/Ω 17 μΩ/Ω 13 μΩ/Ω 13 μΩ/Ω 12 μΩ/Ω 12 μΩ/Ω 14 μΩ/Ω 14 μΩ/Ω 20 μΩ/Ω 21 μΩ/Ω 40 μΩ/Ω 47 μΩ/Ω 0.011 %	Fluke 5700A
	1 Ω  10 kΩ	9.3 μΩ/Ω  7.6 μΩ/Ω	Fluke 742A-1  Fluke 742A-10k
	1 kΩ 10 kΩ 100 kΩ 1 MΩ 10 MΩ 100 MΩ 1 GΩ 10 GΩ 100 GΩ	15 μΩ/Ω 15 μΩ/Ω 20 μΩ/Ω 25 μΩ/Ω 31 μΩ/Ω 0.013 % 0.070 % 0.25 % 0.45 %	Resistance standard
Resistance – Measure <sup>3</sup>	(0 to 2) Ω (2 to 20) Ω (20 to 200) Ω (0.2 to 2) kΩ (2 to 20) kΩ (20 to 200) kΩ (0.2 to 2) MΩ (2 to 20) MΩ (20 to 200) MΩ (0.2 to 2) GΩ	17 μΩ/Ω + 4.8 μΩ 8.9 μΩ/Ω + 30 μΩ 7.9 μΩ/Ω + 60 μΩ 7.9 μΩ/Ω + 0.67 mΩ 7.7 μΩ/Ω + 10 mΩ 8.0 μΩ/Ω + 55 mΩ 8.7 μΩ/Ω + 1.6 Ω 20 μΩ/Ω + 0.11 kΩ 0.012 % + 10 kΩ 0.15 % + 1.0 MΩ	Fluke 8508A

VI. Electrical – RF/Microwave

Parameter/Range	Frequency	CMC <sup>2, 13</sup> (±)	Comments
RF Power – Generate <sup>3</sup> (-127 to 13) dBm (-60 to 10) dBm	(0.25 to 1) GHz (1 to 3) GHz	1.2 dB 1.2 dB	HP E4432B signal generator
RF Power – Measure <sup>3</sup> (-70 to -20) dBm (-20 to 20) dBm	10 MHz to 18 GHz 100 kHz to 4.2 GHz	0.54 dBm 0.54 dBm	HP 437B w/ HP 8481D, 8482A power sensors, power meter

VII. Fluid Quantities

Parameter/Equipment	Range	CMC <sup>2, 9</sup> (±)	Comments
Air Velocity – Anemometers, Thermal, Pitot, Vane Style and Similar Equipment	(30 to 250) fpm (250 to 1500) fpm (1500 to 9000) fpm	(2.5 + 0.006 <i>F</i> ) fpm (1.2 + 0.011 <i>F</i> ) fpm (5.3 + 0.0083 <i>F</i> ) fpm	Wind tunnel, ΔP measurement with density correction for standard condition normalization  <i>F</i> is the numerical value of the air velocity measured in fpm
Leak Rate <sup>3</sup> – Pressure Decay, Leak Orifices, Standards and Plates	(1 to 10) sccm (10 to 1000) sccm	0.25 sccm 0.22 %	Fluke Molbloccs
Hydrometers <sup>3</sup>	(0.6 to 0.64) sg (0.64 to 1.67) sg (1.67 to 2.0) sg	0.0025 sg 0.0014 sg 0.0049 sg	ASTM E126

Parameter/Equipment	Range	CMC <sup>2,9</sup> (±)	Comments
Mass & Volumetric Flow <sup>3</sup> –  Gas – Meters, Controllers, Rotameters and Leak Orifices  Liquid – Meters, Controllers, Rotameters and Leak Orifices	1 to 10 sccm 10 to 1000 sccm 1 to 1000 slm  (10 to 400) gpm  (0.01 to 10) gpm	0.25 sccm 0.22 % 0.22 %  (0.015 + 0.0057 <i>G</i> ) gpm  (0.0018 + 0.14 <i>G</i> ) gpm	Fluke Molbloccs  By comparison to flow standard in closed loop system, density correction applied  Measured by time and weight; density correction applied  <i>G</i> is the numerical value of the flow measured in gpm
Kinematic Viscosity <sup>3</sup> – Viscometers	< 10 mm <sup>2</sup> /s (11 to 100) mm <sup>2</sup> /s (101 to 1000) mm <sup>2</sup> /s (1001 to 10 000) mm <sup>2</sup> /s (10 001 to 100 000) mm <sup>2</sup> /s	0.25 % 0.32 % 0.37 % 0.44 % 0.51 %	OEM specifications
Viscosity Cups –  Zahn  Shell  Ford	(5 to 1800) mm <sup>2</sup> /s (35 to 80) s  (2 to 1300) mm <sup>2</sup> /s (20 to 80) s  (2 to 1400) mm <sup>2</sup> /s (20 to 120) s	2.2 %  2.2 %  2.2 %	Certified reference viscosity standards  ASTM D4212  ASTM D1200
Piston Operated Volumetric Apparatus <sup>3, 12</sup> – – Pipettes, Syringes, Burettes, Liquid, Handlers, Dispensers	(1 to 2000) µL (2000 to 10 000) µL (10 000 to 100 000) µL	0.094 µL 0.22 µL 2.0 µL	Gravimetric method referenced to mass balances and ASTM Class 1 mass standards

Parameter/Equipment	Range	CMC <sup>2,9,13</sup> (±)	Comments
Volume – Measuring Equipment <sup>3</sup>	(0.001 to 4000) mL	2.5 mL	ASTM E542, burettes graduated “to deliver”, graduated cylinders, volumetric flasks, specific gravity flasks, measuring and dilution pipettes, and transfer and capacity pipettes

VIII. Mechanical

Parameter/Equipment	Range	CMC <sup>2,9</sup> (±)	Comments
Force <sup>3</sup> – Load Cells, Tensile & Compression Testers and Force Gauges	(25 to 250) cN (250 to 2000) cN	5.2 cN 52 cN	Gram gauge
	(0.01 to 500) lbf (500 to 1000) lbf (1000 to 2000) lbf	0.011 % 0.030 % 0.015 %	Primary and secondary force standards
	(100 to 10 000) lbf (100 to 50 000) lbf (100 to 100 000) lbf	(0.000 32 <i>F</i> + 0.31) lbf (0.000 31 <i>F</i> + 2.0) lbf (0.000 31 <i>F</i> + 3.9) lbf	<i>F</i> is the numerical value of the nominal value of force measured in pound force



Parameter/Equipment	Range	CMC <sup>2,9</sup> (±)	Comments
Durometers <sup>3</sup> –			
Indenter Extension and Shape			
Extension	Up to 0.2 in	160 μin	ASTM D2240 optical inspection under magnification
Diameter	Diameter of the base of the frustum	170 μin	
	Diameter of the top of the frustum	170 μin	
	Diameter of the base of the cone	170 μin	
Angle			
35° right circular conical frustum	Cone angle	0.1°	
30° cone	Cone angle	0.1°	
Radius	Tip radius	170 μin	
Indenter Display	Indenter thickness Indenter radius	170 μin 160 μin	
Spring Calibration	(0 to 100) duro units	0.89 duro units	Durometer calibrator
Indirect Verification of Rockwell Hardness Testers <sup>3</sup>	HRBW (80 to 100) HRBW (60 to 79) HRBW (40 to 59) HRBW  HRC (60 to 65) HRC (35 to 55) HRC (20 to 30) HRC	0.48 HRBW 0.77 HRBW 1.1 HRBW  0.37 HRC 0.48 HRC 0.57 HRC	ASTM E18
Mass <sup>3</sup>	1 mg to 5 g (5 to 30) g (30 to 200) g (200 to 500) g (500 to 2000) g (2 to 10) kg (10 to 30) kg (30 to 45) kg	0.021 mg 0.024 mg 0.21 mg 2.1 mg 21 mg 0.21 g 0.24 g 0.45 g	NISTIR 6969 OIML R 111-1

Parameter/Equipment	Range	CMC <sup>2,9</sup> (±)	Comments
Pressure <sup>3</sup> – Absolute, Gauge, Negative Gauge Mode Transducers, Indicators, Controllers and Gauges	(-104 to -7.5) kPa (-7.5 to -2.9) kPa (-2.9 to -0.75) kPa (-0.75 to 0.75) kPa (0.75 to 2.9) kPa (2.9 to 7.5) kPa (7.5 to 26) kPa (26 to 63) kPa (63 to 700) kPa (700 to 7000) kPa (7000 to 82 737) kPa	0.0077 % + 5.2 Pa 0.0091 % 0.0090 % + 0.035 Pa 0.0075 % + 0.051 Pa 0.0090 % + 0.035 Pa 0.0091 % 0.0077 % + 1.3 Pa 0.009 % + 0.05 Pa 0.008 % + 0.0007 kPa 0.008 % + 0.0003 kPa 50 parts in 10 <sup>6</sup>	Secondary standards          Piston gauge
Shore – Durometer Calibrators <sup>3</sup>			
Dimensional	Up to 8 in	480 μin	Optical comparison
Mass	(0 to 4) kg	30 mg	Single substitution
Vacuum <sup>3</sup> – Gauges, Controllers and Transducers	(0.004 to 1) Torr (1 to 1000) Torr	0.98 % 0.25 %	Capacitance transducer
Rotation – Measure <sup>3</sup> Belt Speed, Line Speed, Centrifuges, and Mechanical Tachometers	(6 to 8 300) rpm (8300 to 99 999) rpm  (6 to 8300) rpm (8300 to 99 999) rpm	1.7 rpm 2.6 rpm  2.4 rpm 3 rpm	Optical measurement method  Contact measurement method



IX. Optical Quantities

Parameter/Equipment	Range	CMC <sup>2,9</sup> (±)	Comments
Light Meters –	(0 to 40) lux (40 to 400) lux (400 to 4000) lux (4000 to 40 000) lux (40 000 to 400 000) lux	3.6 % + 0.2 lux 3.6 % + 2.0 lux 3.6 % + 20 lux 4.5 % + 200 lux 4.5 % + 2000 lux	Comparison to standard light meter

X. Thermodynamics

Parameter/Equipment	Range	CMC <sup>2,4,13</sup> (±)	Comments
Dew Point <sup>3</sup> –			
Measuring Equipment	(-25 to 68) °C	0.15 °C	Thunder 2500
Measure	(-15 to 20) °C	0.26 °C	Chilled mirror
Infrared Thermometers <sup>3</sup>	(-15 to 0) °C (0 to 100) °C (100 to 120) °C (120 to 200) °C (200 to 350) °C (350 to 500) °C (500 to 1200) °C	0.65 °C 0.78 °C 0.83 °C 1.0 °C 1.7 °C 2.3 °C 4.0 °C	Blackbody source E = 0.95
Relative Humidity <sup>3</sup> –			
Measuring Equipment	(10 to 95) % RH	0.28 % reading + 0.24 % RH	Thunder 2500
Measure	(10 to 95) % RH	1.3 % RH	Chilled mirror

Parameter/Equipment	Range	CMC <sup>2, 4, 13</sup> ( $\pm$ )	Comments
Temperature – Measuring Equipment <sup>3</sup>			
Triple Point of Water	0.010 °C	1 mK	Fixed point
	-197 °C	4.0 mK	ITS-90 SPRT by comparison. Fluke 1595A and SPRT
	-100 °C to 300 °C	5.0 mK	
	>300 °C to 420 °C	4.0 mK	
	>420 °C to 500 °C	4.5 mK	
	>500 °C to 660 °C	5.5 mK	
PRT, RTD, Thermistor, Thermocouple, Stirred and Dry Baths	(-80 to 660) °C (660 to 1250) °C	10 mK 18 mK	SPRT & indicator T/C & indicator

#### XI. Time & Frequency

Parameter/Equipment	Range	CMC <sup>2, 13</sup> ( $\pm$ )	Comments
Frequency – Measuring Equipment <sup>3</sup>	10 MHz	0.000 050 $\mu$ Hz/Hz	Fluke 910R GPS frequency standard
	1 $\mu$ Hz to 80 MHz	0.58 $\mu$ Hz/Hz	Agilent 33250A
	250 kHz to 3 GHz	0.58 $\mu$ Hz/Hz	Agilent E4432B
Frequency – Measure <sup>3</sup>	1 Hz to 12.4 GHz	0.000 051 $\mu$ Hz/Hz	Agilent 53132A
Stop Watches & Timers <sup>3</sup>	(0.1 to 1000) s (0.1 to 86 400) s	600 $\mu$ s/s + 0.3 s 0.0015 $\mu$ s/s + 0.3 s	EAI C-510 Agilent 53132A
Tachometer – Optical Pickup <sup>3</sup>	(0 to 60 000) rpm	0.36 rpm	Agilent 33250A

<sup>1</sup> This laboratory offers commercial dimensional testing/calibration and field calibration service.

<sup>2</sup> Calibration and Measurement Capability Uncertainty (CMC) is the smallest uncertainty of measurement that a laboratory can achieve within its scope of accreditation when performing more or less routine calibrations of nearly ideal measurement standards or nearly ideal measuring equipment. CMCs represent expanded uncertainties expressed at approximately the 95 % level of confidence, usually using a coverage factor of  $k = 2$ . The actual measurement uncertainty of a specific calibration performed by the laboratory may be greater than the CMC due to the behavior of the customer's device and to influences from the circumstances of the specific calibration.

- <sup>3</sup> Field calibration service is available for this calibration and this laboratory meets A2LA R104 – *General Requirements: Accreditation of Field Testing and Field Calibration Laboratories* for these calibrations. Please note the actual measurement uncertainties achievable on a customer's site can normally be expected to be larger than the CMC found on the A2LA Scope. Allowance must be made for aspects such as the environment at the place of calibration and for other possible adverse effects such as those caused by transportation of the calibration equipment. The usual allowance for the actual uncertainty introduced by the item being calibrated, (e.g. resolution) must also be considered and this, on its own, could result in the actual measurement uncertainty achievable on a customer's site being larger than the CMC.
- <sup>4</sup> In the statement of CMC,  $L$  is the numerical value of the nominal length of the device measured in inches,  $R$  is the resolution of the device measured in inches, and  $D$  is the diameter measured in inches.  $C$  is the numerical value of the nominal value of the temperature measured in degrees Celsius.
- <sup>5</sup> Volumetric results have similar uncertainty but are dependant upon the thermal coefficients of the measured liquid.
- <sup>6</sup> CMC is to be no less than the acceptable closure error for the procedure.
- <sup>7</sup> The measurands stated are generated with the Fluke 5520A, 5700A, 5500A, & 8508A series of instruments. This capability is suitable for the calibration of the devices intended to measure the stated measurand in the ranges indicated. Calibration and Measurement Capability is expressed as either a specific value that covers the full range, as a percentage of the reading, or a combination of the two.
- <sup>8</sup> This laboratory meets R205 – *Specific Requirements: Calibration Laboratory Accreditation Program* for the types of dimensional tests listed above and is considered equivalent to that of a calibration.
- <sup>9</sup> In the statement of CMC, percent should be read as a percentage of the reading, unless otherwise noted.
- <sup>10</sup> The contributions from the “best existing device” are not included in the CMC claim.
- <sup>11</sup> The CMC includes worst case unit under test insulation resistance effects.
- <sup>12</sup> This scope meets A2LA's *P112 Flexible Scope Policy*.
- <sup>13</sup> The type of instrument or material being calibrated is defined by the parameter. This indicates the laboratory is capable of calibrating instruments that measure or generate the values in the ranges indicated for the listed measurement parameter.



## *Accredited Laboratory*

A2LA has accredited

**TANGENT LABS, LLC**

*Indianapolis, IN*

for technical competence in the field of

**Calibration**

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005 *General requirements for the competence of testing and calibration laboratories*. This laboratory also meets the requirements of ANSI/NCSLI Z540-1-1994 and R205 – Specific Requirements: Calibration Laboratory Accreditation Program. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communiqué dated April 2017).



Presented this 1<sup>st</sup> day of November 2018.

A handwritten signature in black ink, written over a horizontal line.

President and CEO  
For the Accreditation Council  
Certificate Number 1318.01  
Valid to December 31, 2019

*For the calibrations to which this accreditation applies, please refer to the laboratory's Calibration Scope of Accreditation.*